# **UNIVERSITY OF MUMBAI**



# **Bachelor of Engineering Electronics Engineering**

Final Year Engineering (Sem. VII and VIII), Revised course (REV- 2012) effective from Academic Year 2015 -16

# <u>Under</u> FACULTY OF TECHNOLOGY

(As per Semester Based Credit and Grading System)

# From Dean's Desk:

To meet the challenge of ensuring excellence in engineering education, the issue of quality needs to be addressed, debated and taken forward in a systematic manner. Accreditation is the principal means of quality assurance in higher education. The major emphasis of accreditation process is to measure the outcomes of the program that is being accredited. In line with this Faculty of Technology of University of Mumbai has taken a lead in incorporating philosophy of outcome based education in the process of curriculum development.

Faculty of Technology, University of Mumbai, in one of its meeting unanimously resolved that, each Board of Studies shall prepare some Program Educational Objectives (PEO's) and give freedom to affiliated Institutes to add few (PEO's) and course objectives and course outcomes to be clearly defined for each course, so that all faculty members in affiliated institutes understand the depth and approach of course to be taught, which will enhance learner's learning process. It was also resolved that, maximum senior faculty from colleges and experts from industry to be involved while revising the curriculum. I am happy to state that, each Board of studies has adhered to the resolutions passed by Faculty of Technology, and developed curriculum accordingly. In addition to outcome based education, semester based credit and grading system is also introduced to ensure quality of engineering education. Semester based Credit and Grading system enables a much-required shift in focus from teacher-centric to learner-centric education since the workload estimated is based on the investment of time in learning and not in teaching. It also focuses on continuous evaluation which will enhance the quality of education. University of Mumbai has taken a lead in implementing the system through its affiliated Institutes and Faculty of Technology has devised a transparent credit assignment policy and adopted ten points scale to grade learner's performance. Credit assignment for courses is based on 15 weeks teaching learning process, however content of courses is to be taught in 12-13 weeks and remaining 3-2 weeks to be utilized for revision, guest lectures, coverage of content beyond syllabus etc.

Credit and grading based system was implemented for First Year of Engineering from the academic year 2012-2013. Subsequently this system will be carried forward for Second Year Engineering in the academic year 2013-2014, for Third Year and Final Year Engineering in the academic years 2014-2015 and 2015-2016 respectively.

Dr. S. K. Ukarande Dean, Faculty of Technology, Member - Management Council, Senate, Academic Council University of Mumbai, Mumbai

# **Preamble:**

In the process of change in the curriculum there is a limited scope to have major changes in the fundamental subjects which are mainly part of second year of engineering. The exposure to the latest technology and tools used all over the world is given by properly selecting subjects and their hierarchy in pre-final and final year. Thus this syllabus is made to groom the undergraduate students best suited and competent in all respect with best possible efforts put in by the experts in framing detail contents of individual subjects.

The engineering education in India is expanding in manifolds and the main challenge is the quality education. All the stakeholders are very much concerned about it.

The institution or program of study is committed and open to external review to meet certain minimum specified standards. The major emphasis of this process is to measure the outcomes of the program. Program outcomes are essentially a range of skills and knowledge that a student will have at the time of graduation.

So the curriculum must be constantly refined and updated to ensure that the defined objectives and outcomes are achieved. Students must be encouraged to comment on the objectives and outcomes and the role played by the individual courses in achieving them. In line with this Faculty of Technology of University of Mumbai has taken a lead in incorporating philosophy of outcome based education in the process of curriculum development.

I, as Chairman, Board of Studies in Electronics Engineering University of Mumbai, happy to state here that, heads of the department and senior faculty from various institute took timely and valuable initiative to frame Program Educational Objectives as listed below.

- 1. To provide students with a strong foundation in the mathematical, scientific and engineering fundamentals necessary to formulate, solve and analyze engineering problems and to prepare them for graduate studies.
- 2. To prepare students to demonstrate an ability to identify, formulate and solve electronics engineering problems.
- 3. To prepare students to demonstrate ability to design electrical and electronics systems and conduct experiments, analyze and interpret data.
- 4. To prepare students to demonstrate for successful career in industry to meet needs of Indian and multi-national companies.
- 5. To develop the ability among students to synthesize data and technical concepts from applications to product design.
- 6. To provide opportunity for students to work as part of teams on multidisciplinary projects.
- 7. To promote awareness among students for the life-long learning and to introduce them to professional ethics and codes of professional practice.

These are the suggested and expected main objectives and individual affiliated institute may add further in the list. In addition to Program Educational Objectives, for each course of undergraduate program, objectives and expected outcomes from learner's point of view are also included in the curriculum to support the philosophy of outcome based education. I believe strongly that small step taken in right direction will definitely help in providing quality education to the stake holders.

The subjects offered to undergraduate students in final year are at par to the requirement of industry. The students are also made competent to appear for various competitive examination conducted in India and abroad. The subjects offered are at enough level to

prepare a base of the students to understand and learn latest state of technology. The students are trained in such a way that they become versatile in hardware and software simulation. Some subjects offered upgrades them in the field of information and technology which is a need of today's' era.

At the end I must outset extend my gratitude to all experts who contributed to make curriculum competent at par with latest technological development in the field of electronics engineering.

Dr. D. G. Borse Chairman, Board of Studies (Electronics Engineering)

		5	Semester - V	VII				
Sub Code	Subject Name	Teach	ing Schem	e(Hrs.)		Credits Assi	igned	
		Theory	Practical	Tutorial	Theory	TW/Practical	Tutorial	Total
EXC701	Embedded System Design	04			04			04
EXC702	IC Technology	04			04			04
EXC703	Power Electronics –II	04			04			04
EXC704	Computer Communication Networks	04			04			04
EXC 705X	Elective - I	04			04			04
EXC 706	Project - I					02		02
EXL701	Embedded System Design Laboratory		02			01	5	01
EXL702	IC Technology Laboratory		02			01		01
EXL703	Power Electronics –II Laboratory		02			01		01
EXL704	Computer Communication Networks Laboratory		02			01		01
EXL705X	Elective – I Laboratory		02			01		01
Total		20	10	A	20	07		27
				$)^{\circ}$				

Subject	Subject Name			Exa	mination Sc	heme			
Code				Theory Marks		Term	Practical	Oral	Total
		Ι	nternal	assessment	End Sem.	Work	& Oral.		
		Test	Test	Ave. Of Test 1	Exam				
		1	2	and Test 2					
EXC701	Embedded System	20	20	20	80	-			100
	Design								
EXC702	IC Technology	20	20	20	80				100
EXC703	Power Electronics –II	20	20	20	80				100
EXC704	Computer	20	20	20	80				100
	Communication								
	Networks 💊								
EXC705X	Elective - I	20	20	20	80				100
EXC706	Project -I					25		25	50
EXL701 <	Embedded System					25		25	50
	Design Laboratory								
EXL702	IC Technology					25		25	50
	Laboratory								
EXL703	Power Electronics –II					25		25	50
	Laboratory								
EXL704	Computer					25		25	50
	Communication								
	Networks Laboratory								
EXL705X	Elective – I Laboratory					25		25	50
Total		-		100	400	150	00	150	800

<b>Elective – I</b>	
Code	Name of Elective
EXC7051	Digital Image Processing
EXC7052	Artificial Intelligence
EXC7053	ASIC Verification
EXC7054	Optical Fiber Communication

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#### **Semester -VIII**

			chicster - v	111				
Sub Code	Subject Name	Teach	ing Schem	e(Hrs.)		Credits Assi	igned	
		Theory	Practical	Tutorial	Theory	TW/Practical	Tutorial	Total
EXC801	CMOS VLSI Design	04			04			04
EXC802	Advanced Networking	04			04			04
	Technologies							
EXC803	MEMS Technology	04			04			04
EXC804X	Elective -II	04			04			04
EXC806	Project - II		04			04		04
EXL801	CMOS VLSI Design		02			01		01
	Laboratory							
EXL802	Advanced Networking		02			01	Ŧ	01
	Technologies Laboratory							
EXL803	MEMS Laboratory		02			01		01
EXL804X	Elective –II Laboratory		02			01		01
Total		16	12		16	08		24

Subject	Subject Name			Ex	amination S	Scheme			
Code			Т	heory Marks	X	Term	Practical	Oral	Total
		In	ternal a	ssessment	End	Work	& Oral.		
		Test	Test	Ave. Of	Sem.				
		1	2	Test 1 and	Exam				
				Test 2					
EXC801	CMOS VLSI Design	20	20	20	80	-			100
EXC802	Advanced Networking	20	20	20	80				100
	Technologies								
EXC803	MEMS Technology	20	20	20	80				100
EXC804X	Elective -II	20	20	20	80				100
EXC806	Project - II					50		50	100
EXL801	CMOS VLSI Design	H				25		25	50
	Laboratory								
EXL802	Advanced Networking	H				25		25	50
	Technologies Laboratory								
EXL803	MEMS Technology					25		25	50
	Laboratory								
EXL804X	Elective –II Laboratory					25		25	50
Total				80	320	150		150	700
Total				80	320	150		150	700

# Elective –II

Code	Name of Elective							
EXC8041	Robotics							
EXC8042	Mobile Communication							
EXC8043	Digital Control System							
EXC8044	Biomedical Electronics							
	· ·							

Course Code	Course Name	Te	aching Scho	eme	Credits Assigned				
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total	
EXC701	Embedded System Design	04			04			04	

Course	Course Name		Examination Scheme							
Code			Th	eory Marks		Term	Practical	Oral	Total	
		Int	ternal ass	essment	End Sem.	Work				
		Test 1	Test 2	Ave. Of	Exam					
				Test 1 and						
				Test 2						
<b>EXC701</b>	Embedded	20	20	20	80	-	- (	-	100	
	System Design									

# **Course Pre-requisite:**

- EXC403: Microprocessor and Peripherals
- EXC501: Microcontroller & Applications

# **Course Objectives:**

- 1. To teach scope, usage, requirements, challenges and general design methodology of embedded system
- 2. To apply hardware and software knowledge to develop embedded system applications according to requirement and constraints

# **Course Outcomes:**

# After successful completion of the course student will be able to

- 1. interpret component's functional and electrical specifications and its implication and advantage in design.
- 2. develop their skill to select/choose proper components, approach, and method to develop optimal system.

Module	Unit	Topics	Hrs.
No.	No.		
1		Fundamentals of Embedded System	8
	1.1	Core of the embedded system, Memory, Sensors (resistive, optical, position, thermal) and	
		Actuators (solenoid valves, relay/switch, opto-couplers), Communication Interface,	
		Embedded firmware (RTOS, Drivers, Application programs), Power-supply (Battery	
		technology, Solar), PCB and Passive components, Safety and reliability, environmental	
		issues. Ethical practice.	
	1.2	Characteristics and quality attributes (Design Metric) of embedded system. Real time	
		system's requirements, real time issues, interrupt latency.	
	1.3	Embedded Product development life cycle, Program modeling concepts: DFG, FSM,	
		Petri-net, UML	
2	0.1	Embedded Serial Communication	4
	2.1	Study of basic communication protocols like SPI, SCI (RS232, RS485), I <sup>2</sup> C, CAN, Field-	
		bus (Profibus), USB (v2.0), Bluetooth, Zig-Bee, Wireless sensor network	10
3	2.1	Embedded Hardware and Design	12
	3.1	Low power hardware design (MSP430 / Cortex-M3 based Real time clock and PWM dc	
	2.2	motor control as a case study using on chip timers and watch-dog-timers).	
	3.2	Introduction to ARM-v7-M (Cortex-M3), Comparison of ARM-v7-A (CortexA8), ARM- v7-B (CortexP4) ABM v7-M (Cortex M2)	
	3.3	v7-R (CortexR4), ARM-v7-M (Cortex-M3)	-
	3.3	Direct digital solution using CPLD, FPGA, its advantages, and introduction to related development methodology	
4		Embedded Software, Firmware Concepts and Design	16
-	4.1	Embedded C-programming concepts (from embedded system point of view): Optimizing	10
	7,1	for Speed/Memory needs, Interrupt service routines, macros, functions, modifiers, data	
		types, device drivers, Multithreading programming. (Laboratory work on J2ME Java	
		mobile application).	
	4.2	Basic embedded C programs/applications for ARM-v7, using ARM-GCC-tool-chain,	
	-	Emulation of ARM-v7 (e.g. using QEMU), and Linux porting on ARM-v7 (emulation)	
		board	
	4.3	Real time operating system: POSIX Compliance, Need of RTOS in Embedded system	
		software, Foreground/Background systems, multitasking, context switching, IPC,	
		Scheduler policies, Architecture of kernel, task scheduler, ISR, Semaphores, mailbox,	
		message queues, pipes, events, timers, memory management, RTOS services in contrast	
		with traditional OS.	-
	4.4	Introduction to $\mu$ COS-II RTOS, study of kernel structure of $\mu$ COS-II, Synchronization in	
		$\mu$ COS-II, Inter-task communication in $\mu$ COS-II, Memory management in $\mu$ COS-II,	
		porting of RTOS on ARM-v7 (emulation) board, Application developments using $\mu$ COS-	
	4 -		-
	4.5	Introduction Linux OS, Linux IPC usage, basic device (drivers) usage.	0.4
5	E 1	Simulation, Testing and Debugging Methodology and Tools	04
	5.1	GNU Debugger (gdb), Boundary-Scan/JTAG interface concepts, Black-box, White-box	
6		testing, Hardware emulation, logic analyzer.	08
0	6.1	Embedded System Designing Requirement analysis, Hardware blocks diagram, System model (like FSM, UML),	00
	1.0	Software architectures (modules, drivers), and Component/hardware selection, covering	
		following cases: Hard real time/ Mission critical: Missile, Car cruise control, medical	
-		monitoring systems, process control system (temp, pressure) Soft real time: Automated	
		vending machines, digital camera, media-player. Communication: Embedded web servers,	
		routers, Wireless (sensor) networks.	
		Total	52

- 1. Embedded Systems, Rajkamal, TMH, 2008.
- 2. Frank Vahid Embedded Systems, Wiley India, 2002
- 3. ARM System-on-Chip Architecture, Steve Furber Pearson 2005
- 4. Jean J Labrose MicroC / OS-II, Indian Low Price Edition 2002
- 5. DR.K.V.K.K. Prasad Embedded / real time system, Dreamtech
- 6. Iyer, Gupta Embedded real systems Programming, TMH
- 7. Embedded systems software primer, David Simon Pearson
- ARM System Developers Guide- Sloss, Symes, Wright, ElsevierMorgan Kaufman, 2005
- 9. LPC2148 Data Sheets www.arm.com
- 10. ARM Programers/architectural manual.
- 11. MSP430 architectural manual.
- 12. Embedded Microcomputer Systems Real Time Interfacing Jonathan W. Valvano; Cengage Learning; Third or later edition.

#### **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered for final internal assessment.

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining question will be selected from all the modules.

Subject Code	Subject Name	Те	aching Sch	eme	Credits Assigned			
		Theory	Theory Practical Tutorial			<b>TW/Practical</b>	Tutorial	Total
EXC702	IC	04			04			04
	Technology							

Subject	Subject				Examination S	Scheme				
Code	Name			<b>Theory Mar</b>	·ks	Term	Practical	Oral	Total	
		Int	ernal as	ssessment	End Sem.	Work				
		Test	Test	Avg. of	Exam					
		1	2	Test 1 and						
				Test 2						
EXC702	IC	20	20	20	80				100	
	Technology									

# **Course Pre-requisite:**

- EXC302: Electronic Devices
- EXC303: Digital Circuits and Design
- EXC402: Discrete Electronic Circuits
- EXC502: Design With Linear Integrated Circuits
- EXC601: VLSI Design

#### **Course Objectives:**

- 1. To teach fundamental principles of fabrication of VLSI devices and circuits
- 2. To disseminate knowledge about novel VLSI devices

#### **Course Outcomes:**

# After successful completion of the course student will be able to

- 1. demonstrate a clear understanding of CMOS fabrication flow and technology scaling
- 2. demonstrate a clear understanding of various MOS fabrication processes, semiconductor measurements, packaging, testing and advanced semiconductor technologies
- 3. discuss physical mechanism in novel devices
- 4. verify processes and device characteristics via simulations

Module	Unit	Topics	Hrs.
No.	No.		
1.0		Environment and Crystal Growth for VLSI Technology	8
	1.1	Environment: Semiconductor technology trend, Clean rooms, Wafer cleaning	
	1.2	Semiconductor Substrate: Phase diagram and solid solubility, Crystal structure,	
		Crystal defects, Czochralski growth, Bridgman growth of GaAs, Float Zone growth,	
• •		Wafer Preparation and specifications	10
2.0		Fabrication Processes Part 1	10
	2.1	<b>Deposition:</b> Evaporation, Sputtering and Chemical Vapor Deposition	
	2.2	Epitaxy: Molecular Beam Epitaxy, Vapor Phase Epitaxy, Liquid Phase Epitaxy,	
		Evaluation of epitaxial layers	
	2.3	Silicon Oxidation: Thermal oxidation process, Kinetics of growth, Properties of	
		Silicon Dioxide, Oxide Quality, high $\kappa$ and low $\kappa$ dielectrics	
	2.4	<b>Diffusion:</b> Nature of diffusion, Diffusion in a concentration gradient, diffusion	
		equation, impurity behavior, diffusion systems, problems in diffusion, evaluation of	
	25	diffused layers	
	2.5	<b>Ion Implantation:</b> Penetration range, ion implantation systems, process	
3.0		considerations, implantation damage and annealing <b>Fabrication Processess Part 2</b>	10
5.0	2 1	<b>Etching:</b> Wet chemical etching, dry physical etching, dry chemical etching, reactive	10
	3.1		
	3.2	ion etching, ion beam techniques Lithography: Photoreactive materials, Pattern generation and mask making, pattern	
	5.4	transfer, Electron beam, Ion beam and X-ray lithography	
	3.3	<b>Device Isolation, Contacts and Metallization:</b> Junction and oxide isolation,	
	5.5	LOCOS, trench isolation, Schottky contacts, Ohmic contacts, Metallization and	
		Packaging	
	3.4	CMOS Process Flow: N well, P-well and Twin tub	
	3.5	Design rules, Layout of MOS based circuits (gates and combinational logic), Buried	
	5.5	and Butting Contact	
4.0		Measurements, Packaging and Testing	10
<b></b>	4.1	Semiconductor Measurements: Conductivity type, Resistivity, Hall Effect	10
	-101	Measurements, Drift Mobility, Minority Carrier Lifetime and diffusion length	
	4.2	<b>Packaging:</b> Integrated circuit packages, Electronics package reliability	
	4.3	<b>Testing:</b> Technology trends affecting testing, VLSI testing process and test	
		equipment, test economics and product quality	
5.0		SOI, GaAs and Bipolar Technologies	08
	5.1	<b>SOI Technology:</b> SOI fabrication using SIMOX, Bonded SOI and Smart Cut, PD	
		SOI and FD SOI Device structure and their features	
	5.2	GaAs Technologies: MESFET Technology, Digital Technologies, MMIC	
		technologies, MODFET and Optoelectronic Devices	
	5.3	Silicon Bipolar Technologies: Second order effects in bipolar transistor,	
		Performance of BJT, Bipolar processes and BiCMOS	
6.0		Novel Devices	06
	6.1	Multigate Device: Various multigate device configurations (device structure and	_
		important features)	
	6.2	Nanowire: Fabrication and applications	
	6.3	Graphene Device: Carbon nanotube transistor fabrication, CNT applications	
		Total	52

- 1. James D. Plummer, Michael D. Deal and Peter B. Griffin, "Silicon VLSI Technology", Pearson, Indian Edition.
- 2. Stephen A. Campbell, "*The Science and Engineering of Microelectronic Fabrication*", Oxford University Press, 2<sup>nd</sup> Edition.
- 3. Sorab K. Gandhi, "VLSI Fabrication Principles", Wiley, Student Edition.
- 4. G. S. May and S. M. Sze, "Fundamentals of Semiconductor Fabrication", Wiley, First Edition.
- 5. Kerry Bernstein and N. J. Rohrer, "SOI Circuit Design Concepts", Kluwer Academic Publishers, 1<sup>st</sup> edition.
- 6. Jean-Pierre Colinge, "FinFETs and Other Multigate Transistors", Springer, 1st edition
- 7. M. S. Tyagi, "Introduction to Semiconductor Materials and Devices", John Wiley and Sons, 1<sup>st</sup> edition.
- 8. James E. Morris and Krzysztol Iniewski, "Nanoelectronic Device Applications Handbook", CRC Press
- 9. Glenn R. Blackwell, "The electronic packaging", CRC Press
- 10. Michael L. Bushnell and Vishwani D. Agrawal, "Essentials of Electronic Testing for digital, memory and mixed-signal VLSI circuits", Springer

#### **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining question will be selected from all the modules.

Subject	Course	Teaching		Credits Assigned								
Code	Name	Scheme										
		Theory	Practical	Tutorial	Theory	TW/	Tutorial	Total				
						Practical						
<b>EXC703</b>	Power	04			04			04				
	Electronics											
	II											

Course	Course				Examination Sci	heme			
Code	Name			Theory Mar	·ks	Term	Practical	Oral	Total
		Int	ernal as	ssessment	End Sem. Exam	Work			
		Test	Test	Avg. of			C		
		1	2	Test 1 and					
				Test 2					
EXC703	Power	20	20	20	80				100
	Electronics								
	Π								

#### **Course Pre-requisites:**

- EXC 604: Power Electronics I
- EXC 404: Principles of Control Systems

# **Course Objectives:**

- 1. To enhance and expand the ideas of students for more complex power electronic systems.
- 2. To teach the analytical methods in power electronic systems.
- 3. To expose the students to various applications of power electronics in various electronics equipments and drives.

# **Course Outcomes:**

After successful completion of the course students will be able to:

- 1. Thoroughly understand the modern methods of analysis and control of power electronic systems.
- 2. Carry out the theoretical analysis of the power electronic systems from the 'Systems Theory' point of view.
- 3. Appreciate the ubiquity of power electronics systems in engineering fields
- 4. Simulate and analyze power electronic systems

Module	Unit	Topics	Hrs.
<u>No.</u> 1	No.	Rectifiers and Inverters:	12
1	1.1	Effect of source inductance in 1-phase and 3-phase rectifiers, distortion in line current waveforms, voltage distortion for diode and SCR based rectifiers	12
	1.2	PWM for 3-phase voltage source inverters, Space Vector Modulation (SVM) technique for 3-phase voltage source inverters, hysteresis control.	
2		DC-DC Converters:	10
	2.1	Average model, linearized and transfer function models, state-space average models of basic buck, boost and buck-boost converters, Feedback control of these converters (PI and PID).	
3		Power Electronic Applications	06
	3.1	Use of power electronic systems in SMPS, Battery charging systems, UPS and Induction heating.	
4		Power Electronic Applications in DC Drives	10
	4.1	Various schemes of DC motor speed control, single-phase half-wave semi converter & full converter drive for separately excited DC motor, Dynamic and Regenerative braking of DC motor	
5		Power Electronic Applications in AC Drives	14
	5.1	Introduction to speed control of three-phase induction motor methods: i) Stator voltage ii) Variable frequency iii) Rotor resistance iv) V/f control v) Regenerative braking.	
		Total	52

- 1. M. Rashid, Power Electronics: Circuits, Devices, and Applications, PHI, 3<sup>rd</sup> Edition.
- 2. By M. D. Singh, K. B. Khanchandani, Power Electronics, Tata McGraw Hill, 2<sup>nd</sup> Edition.
- 3. Mohan, Undeland and Riobbins, Power Electronics: Converters, Applications and Design, Wiley (Student Edition), 2<sup>nd</sup> Edition.
- 4. P. S. Bimbhra, Power Electronics, Khanna Publishers, 2012.
- 5. R. W. Erickson, D. Maksimovic, Fundamentals of Power Electronics, Springer, 2<sup>nd</sup> Edition.
- 6. J. P. Agrawal, Power Electronics Systems: Theory and Design, Pearson Education, 2002.
- 7. S. Bacha, I. Munteanu and A. Bratcu, Power Electronic Converters: Modeling and Control, Springer-Verlag, 2014.
- 8. H. Sira-Ramírez, R. Silva-Ortigoza, Control Design Techniques in Power Electronics Devices, Springer-Verlag, 2006

#### **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining questions will be selected from all the modules

Course Code	Course Name	Te	aching Sch	eme	Credits Assigned					
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total		
EXC704	Computer	04			04			04		
	Communication									
	and Networks									

Course	Course Name				Examination S	Scheme				
Code				<b>Theory Marks</b>	S	Term	Practical	Oral	Total	
		Int	ternal a	ssessment	End Sem.	Work				
		Test	Test	Ave. Of	Exam					
		1	2	Test 1 and						
				Test 2						
<b>EXC704</b>	Computer	20	20	20	80	-	-		100	
	Communication									
	and Networks									

# Pre requisite :

- EXC 405: Fundamentals of Communication Engineering
- EXC:504: Digital Communication

# **Course Objective:**

- 1. To ensure that students have the necessary networking skills to design, implement and analyze communication networks.
- 2. Students will be able to design, implement, and analyze communication networks.

**Course Outcome**: After Completing this course student will be able to

- 1. Understand the fundamentals of communication and Computer networks.
- 2. Have the capability of designing and analyzing data transmission protocols and data link control protocols.
- 3. Able to discuss major trends in industry and current research activities within the discipline.
- 4. Able to implement networking protocols using TCP/IP based on socket programming.

Module	Unit	Topics	Hrs.
<u>No.</u>	No.	Introduction to Naturally Anabitasturg Ductocal Lawang and Coursias models	10
1.	1.1	Introduction to Network Architectures, Protocol Layers, and Service models	10
	1.1	Network Hardware: Topologies, LAN, MAN, WAN, Wireless network, Home	
	1.2	Network, Internetworks, Virtual LANs Network Software: Protocol Hierarchies, Design Issues for the layers, Connection	
	1.4	oriented and connectionless Services	
	1.3	Reference Models: Layers details of OSI, TCP/IP Models, Protocol Layers and	
	1.5	Their Service Models	
2		Physical-layer Services and Systems	08
4	2.1	Introduction to physical media, Coax, fiber, twisted pair, DSL, HFC	00
	2.1	Data link layer services and protocols: Link-layer and its services, Ethernet, hubs,	
	2.2	bridges, and switches, Link- layer addressing, Error-detection and error-correction.	
		Parity, check-summing, CRC, Manchester encoding. Aloha protocols, Control	
		Access Protocol, Carrier Sense	
	2.3	Multiple Access (CSMA), Local Area Networks - Ethernet, Token ring, FDDI.	
	2.5	WiMax, cellular, satellite, and telephone networks, Bit transmission, Frequency	
		division multiplexing. Time division multiplexing	
3		Data Link Layer Protocol	10
U	3.1	PPP, HDLC, Stop and wait protocol	10
4	011	Network Layer Services and Protocols	10
-	4.1	Switching fabric, Routing and forwarding, Queues and buffering, Virtual-circuit and	
		datagram networks, Internet protocol	
	4.2	IPv4 and IPv6, Tunneling, LS and DV algorithms. Routing in the Internet, RIP,	
		OSPF, and BGP	
	4.3	Broadcast and multicast, Handling mobility	
5		Reliable and Unreliable Transport-layer Protocols	08
	5.1	GBN and SR. TCP and UDP. Port numbers, Multiplexing and de-multiplexing	
	5.2	Flow control and congestion control. Fairness, Delay, jitter, and loss in packet-	
		switched networks	
	5.3	Bandwidth, throughput, and quality-of-service	
6		Principles of Network Applications.	06
	6.1	Application layer protocols such as HTTP, FTP, and SMTP,	
	6.2	Peer-to-Peer File Sharing Protocols and Architectures, ISPs and Domain name	
		systems, Socket API and network socket programming	
		Total	52

7

- 1. B. A. Forouzan, "Data Communications and Networking", TMH, Fourth Edition.
- 2. S. Tanenbaum, "Computer Networks", Pearson Education, Fourth Edition.
- 1. Computer Networking: A Top-Down Approach, by J. F. Kurose and K. W. Ross, Addison Wesley, 5th Edition, March 2009, ISBN-13: 978-0136079675.

### **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining questions will be selected from all the modules

Course Code	Course Name	Те	aching Sch	eme	Credits Assigned				
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total	
EXC7051	Digital Image Processing	04			04			04	

Course	Course				Examination Sc	heme			
Code	Name			Theory Mar	:ks	Term	Practical	Oral	Total
		Internal assessment			End Sem.	Work			
		Test	Test	Ave. Of	Exam				
		1	2	Test 1 and					
				Test 2					
EXC7051	Digital	20	20	20	80	-	- (	1	100
	Image								
	Processing								

# **Course Pre-requisite:**

- EXS 401 : Applied Mathematics IV
- EXC 504 : Signal and Systems

# **Course Objectives:**

- 1. To develop an overview of the field of image processing
- 2. To learn the fundamental concepts of Digital Image Processing
- 3. To understand basic image enhancement and segmentation techniques.
- 4. To illustrate Image Transform calculations mathematically and develop fast transform algorithm
- 5. To learn Image Compression and Decompression Techniques

# **Course Outcomes:**

# After successful completion of the course student will be able to

- 1. Understand the concept of Digital Image processing.
- 2. Explain image enhancement and Segmentation technique.
- 3. Understand Digital Image compression and decompression techniques
- 4. Perform Binary Image Processing Operations

<u>No.</u> 1	Unit No.	Topics	Hr
		Digital Image Processing Fundamentals	06
-	1.1	<b>Introduction:</b> Background, Digital Image Representation, Fundamental Steps in	
		Image Processing, Elements of a Digital Image Processing System	
-	1.2	<b>Digital Image Fundamentals:</b> Elements of Visual Perception, A Simple Image	-
	<b>1</b> • <b></b>	Model, Sampling and Quantization, Some Basic Relationships between Pixels,	
	l	Imagining Geometry. Image File Formats : BMP, TIFF and JPEG. Colour Models	
	l	(RGB, HSI, YUV)	
2		Image Enhancement	08
-	2.1	Spatial Domain Methods, Frequency Domain Methods, Some Simple Intensity	
	<i>4</i> •1	Transformations, Histogram Processing, Image Subtraction, Image Averaging,	
	l	Background	
	2.2	Smoothing Filters, Sharpening Filters, Lowpass Filtering, Highpass Filtering,	1
	<u>م</u> .م	Generation of Spatial Masks from Frequency Domain Specifications. Homomorphic	
	l	Filtering.	
3		Image Segmentation and Representation	08
5	3.1	Detection of Discontinuities, Edge Linking using Hough Transform, Thresholding,	
	J.1	Region based Segmentation, Split and Merge Technique,	
-	3.2	Image Representation and Description, Chain Code, Polygonal, Representation,	-
	J.4	Shape Number, Moments.	
4		Binary Image Processing	06
4	4.1	Binary Morphological Operators, Hit-or-Miss Transformation, Boundary Extraction,	
	4.1		
	l	Region Filling, Thinning and Thickening, Connected Component Labeling, Iterative	
5		Algorithm and Classical Algorithm	12
5	<b>5</b> 1	Image Transform	
	5.1	Introduction to the Fourier Transform, The Discrete Fourier Transform, Some	
	l	Properties of the Two-Dimensional Fourier Transform Fast Fourier	
	5 3	Transform(FFT), Discrete Hedemard Transform(DHT) Fast Hedemard Transform(FHT) Discrete	-
	5.2	Discrete Hadamard Transform(DHT), Fast Hadamard Transform(FHT), Discrete	
4		Cosine Transform(DCT), Discrete Wavelet Transform(DWT),	12
6		Image Compression:	12
	l	Fundamentals – Coding Redundancy, Interpixel Redundancy, Psychovisual	
ŀ	< 1	Redundancy, Fidelity Criteria.	-
	6.1	Image Compression Models – The Source Encoder and Decoder, Lossless	
	l	Compression Techniques : Run Length Coding, Arithmetic Coding, Huffman Coding, Differential PCM,	
		Coding, Differential PCIVI,	
-	<u> </u>	Comparation Techniques Improved Grove Scale Quantization Vector	1
	6.2	Lossy Compression Techniques: Improved Gray Scale Quantization, Vector	
	6.2	Lossy Compression Techniques: Improved Gray Scale Quantization, Vector Quantization, JPEG, MPEG-1.	

- 1. Rafel C. Gonzalez and Richard E. Woods, 'Digital Image Processing', Pearson Education Asia, Third Edition, 2009,
- 2. S. Jayaraman, E.Esakkirajan and T.Veerkumar, "Digital Image Processing" TataMcGraw Hill Education Private Ltd, 2009,
- 3. Anil K. Jain, "Fundamentals and Digital Image Processing", Prentice Hall of India Private Ltd, Third Edition

# **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining questions will be selected from all the modules

Course Code	Course Name	Te	aching Sch	eme	Credits Assigned				
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total	
EXC7052	Artificial Intelligence	04			04			04	

Course	Course			F	Examination S	Scheme			
Code	Name		]	Theory Marks	Term	Practical	Oral	Total	
		Iı	nternal a	ssessment	End Sem.	Work			
		Test	Test 2	Ave. Of Test	Exam				
		1		1 and Test 2					
EXC7052	Artificial	20	20	20	80	-	-		100
	Intelligence								

# **Course Prerequisite:**

- Knowledge of linear algebra, multivariate calculus, and probability theory
- Knowledge of a programming language (MATLAB /C/C ++ recommended)

# **Course Objective:**

- 1. To study basics of biological Neural Network.
- 2. To understand the different types of Artificial Neural Networks
- 3. To know the applications of ANN
- 4. To study fuzzy logic and fuzzy systems

# Course Outcome: At the end of completing the course of Artificial Neural Networks, a student will be able to:

- 1. Choose between different types of neural networks
- 2. Design a neural network for a particular application
- 3. Understand the applications of neural networks
- 4. Appreciate the need for fuzzy logic and control

Module No.	Unit No.	Topics	Hrs.
1.		Fundamental Concepts of Neural Networks	8
	1.1	Difference between fuzzy and crisp sets and applications of fuzzy logic and	
	1.2	Biological neurons, McCulloch and Pitts models <i>of</i> neuron, Important Terms of ANNs, McCulloch-Pitts Neuron, Hebb Network, Supervised learning,	
	1.3	Applications and scope of Neural Network	
2		Supervised Learning Networks	12
	2.1	Perception Networks: Adaline, Madaline	
	2.2	Back Propagation Network	
	2.3	Function Network	
3		Unsupervised learning network	12
	3.1	Max Net, Mexican Hat, Kohonen Self-organizing Feature	
	3.2	Maps, Learning Vector Quantization, Adaptive Resonance Theory	
4		Associative networks	10
	4.1	Pattern Association, Auto-associative Memory Network, Hetero-associative Memory Network, Bidirectional Associative Memory, Discrete Hopfield Networks	
	4.2	Special networks: Simulated annealing neural networks, Boltzmann machine, Brain-in-a-Box	
5		Fuzzy logic	10
	5.1	Fuzzy sets, Properties, Operations on fuzzy sets, Fuzzy relation Operations on fuzzy relations,	
	5.2	The extension principle, Fuzzy mean Membership functions, Fuzzification and defuzzification methods	
	5.3	Fuzzy controllers, Adaptive neuro-fuzzy information systems (ANFIS)	
		Total	52

- 1. Simon Haykin, "Neural Network a Comprehensive Foundation", Pearson Education
- 2. Dr.S.N.Sivanandam,Mrs S.N. Deepa Introduction to Soft computing tool Wiley Publication
- 3. Satish Kumar Neural Networks: A classroom Approach Tata McGraw-Hill
- 4. Thimothy J. Ross, "Fuzz V Logic with Engineering Applications", McGraw -Hill
- 5. Rajsekaran S, Vijaylakshmi Pai, Neural Networks, Fuzzy Logic, andGenetic Algorithms, PHI
- 6. Hagan, Demuth, Beale, 'Neural Network Design', Thomson Learning
- 7. Christopher M Bishop Neural Networks For Pattern Recognition ,Oxford Publication
- 8. William W Hsieh Machine Learning Methods in the Environmental Sciences Neural Network and Kernels Cambridge Publication
- 9. Dr.S.N.Sivanandam, Dr.S.Sumathi Introduction to Neural Network Using Matlab Tata McGraw-Hill

#### **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining questions will be selected from all the modules

Subject Code	Subject Name	Те	aching Sch	eme	Credits Assigned				
		Theory	Practical	Tutorial	Theory	<b>TW/Practical</b>	Tutorial	Total	
EXC7053	ASIC Verification	04			04			04	

Subject	Subject				Examination	Scheme					
Code	Name			<b>Theory Mar</b>	ks	Term	Practical	Oral	Total		
		Int	ernal as	ssessment	End Sem.	Work					
		Test	Test	Avg. of	Exam						
		1	2	Test 1 and							
				Test 2							
EXC7053	ASIC	20	20	20	80				100		
	Verification										

# **Course Pre-requisite:**

- EXL304: Object Oriented Programming Methodology Laboratory
- EXC303: Digital Circuits and Design

#### **Course Objectives:**

- 1. To teach ASIC Verification fundamentals
- 2. To highlight the significance of verification in VLSI industry

# **Course Outcomes:**

# After successful completion of the course student will be able to

- 1. demonstrate an understanding of programmable devices and languages
- 2. demonstrate an understanding of verification process in VLSI systems
- 3. write system verilog code for VLSI systems
- 4. carry out verification of design successfully using simulators

Module No.	Unit No.	Topics	Hrs
1		Programmable Devices and Verilog	08
	1.1	<b>Programmable Devices:</b> Architecture of FPGA, CPLD with an example of Virtex-7 and	
		Spartan -6 family devices	
	1.2	Verilog HDL: Data types, expressions, assignments, behavioral, gate and switch level	
		modeling, tasks and functions	
	1.3	Verification Basics: Technology challenges, Verification methodology options,	
		Verification methodology, Testbench creation, testbench migration, Verification languages,	
		Verification IP reuse, Verification approaches, Verification and device test, Verification	
		plans, reference design of Bluetooth SoC, Verification Guidelines	
2		Data types, procedural statements and testbench	08
-	2.1	<b>Data Types:</b> Built in, Fixed size array, dynamic array, queues, associative array, linked list,	
	<b>2</b> •1	array methods, choosing a storage type, creating new types with typedef, creating user-	
		defined structures, type conversion, enumerated types, constants, strings, expression width	
	2.2	<b>Procedural Statements and Routines:</b> Procedural statements, tasks, functions and void	-
	2.2		
		functions, task and function overview, routine arguments, returning from a routine, local	
	<b>•</b> • •	data storage, time values	-
ſ	2.3	<b>Connecting the Testbench and Design:</b> Separating the testbench and design, the interface	
		construct, stimulus timing, interface driving and sampling, connecting it all together, top-	
		level scope, program-module interactions, system verilog assertions, the four port ATM	
		router, the ref port direction, the end of simulation, directed test for the LC3 fetch block	10
3		OOP and Randomization	10
	3.1	Basic OOP: Class, Creating new objects, Object deallocation, using objects, variables, class	
		methods, defining methods outside class, scoping rules, using one class inside another,	
		understanding dynamic objects, copying objects, public vs. local, building a testbench	
	3.2	<b>Randomization:</b> Randomization in system Verilog, constraint details, solution	
		probabilities, controlling multiple constraint blocks, valid constraints, In-line constraints,	
		The pre-randomize and post-randomize functions, Random number functions, Constraints	
		tips and techniques, common randomization problems, Iterative and array constraints,	
		Atomic stimulus generation vs. scenario generation, random control, random number	
		generators, random device configuration	
4		IPC and advanced OOP	08
	4.1	Threads and Interprocess Communication: working with threads, disabling threads,	
		interprocess communication, events, semaphores, mailboxes, building a testbench with	
		threads and IPC	
	4.2	Advanced OOP and Testbench Guidelines: Inheritance, Blueprint pattern, downcasting	
		and virtual methods, composition, inheritance and alternatives, copying an object, abstract	
		classes and pure virtual methods, callbacks, parameterized classes	
5		Assertions and Functional Coverage	12
	5.1	System Verilog Assertions: Assertions in verification methodology, Understanding	1
		sequences and properties, SystemVerilog Assertions in the Design Process, Formal	
		Verification Using Assertions and SystemVerilog Assertions Guidelines	
	5.2	<b>Functional Coverage:</b> Coverage types, strategies, examples, anatomy of a cover group,	1
		triggering a cover group, data sampling, cross coverage, generic cover groups, coverage	
		options, analyzing coverage data, measuring coverage statistics during simulation	
6		Advanced interfaces and interfacing with C	6
J	6.1	Advanced Interfaces: Virtual interfaces with the ATM router, Connecting to multiple	U
	<b>U.1</b>		
	( )	design configurations, procedural code in an interface	1
ŀ	6.2	A complete System Verilog Testbench: Design blocks, testbench blocks, alternate tests	-
	10	International with I' Reging simple values connecting to a simple (' routing connecting to	1
	6.3	<b>Interfacing with C:</b> Passing simple values, connecting to a simple C routine, connecting to	
	6.3	C++, simple array sharing, open arrays, sharing composite types, pure and context imported methods, communicating from C to system verilog, connecting other languages	

- 1. Chris Spear, "System Verilog for Verification: A guide to learning the testbench language *features*", Springer, 2<sup>nd</sup> Edition
- 2. Stuart Sutherland, Simon Davidmann, and Peter Flake, "System Verilog for Design: A guide to using system verilog for hardware design and modeling", Springer, 2<sup>nd</sup> Edition.
- 3. Ben Cohen, Srinivasan Venkataramanan, Ajeetha Kumari and Lisa Piper, "SystemVerilog Assertions Handbook", VhdlCohen Publishing, 3rd edition
- 4. System Verilog Language Reference manual
- 5. S Prakash Rashinkar, Peter Paterson and Leena Singh, "System on Chip Verification" Methodologies and Techniques", Kluwer Academic, 1<sup>st</sup> Edition.
- 6. Spartan and Virtex family user manuals from Xilinx
- 7. Verilog Language Reference manual

#### **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining question will be selected from all the modules.

Course Code	Course Name	Те	aching Sch	eme	Credits Assigned				
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total	
EXC7054	Optical Fiber	04			04			04	
	Communication								

Course	Course Name		Examination Scheme							
Code			I	Theory Mark	S	Term	Practical	Oral	Total	
		Internal assessment			End Sem.	Work				
		Test	Test	Ave. Of	Exam					
		1	2	Test 1 and						
				Test 2						
EXC7054	<b>Optical Fiber</b>	20	20	20	80	-	-		100	
	Communication									

#### **Pre requisites:**

- EXC503: Electromagnetic Engineering
- EXC405: Fundamentals of Communication Engineering
- EXC505: Digital Communication.

# **Course Objective: To teach students**

- 1. Optical fiber wave guide structures, fabrication and signal degradation in fiber
- 2. The characteristics and working of various components used in optical link
- 3. Design and management of optical networks

# Course Outcome: After successful completion of the course student will be able to

- 1. understand light wave propagation through fiber
- 2. identify structures, materials, and components used in optical link
- 3. analyze transmission characteristics of fiber
- 4. design and management of optical fiber links

Module	Unit No.	Topics	Hrs.
<u>No.</u> 1.	190.	Overview of Optical Fiber Communication	10
1.	1.1	The evolution of fiber optic systems, elements of an optical fiber transmission link,	10
	1.1	block diagram, advantages of optical fiber communication, applications	
	1.2	Ray theory transmission, total internal reflection, acceptance angle, numerical	
	1.4	aperture and skew rays	
	1.3	Modes, electromagnetic mode theory and propagation, single mode and multimode	
	1.5	fibers, linearly polarized modes	
	1.4	Fiber material, fiber cables and fiber fabrication, fiber joints, fiber connectors, splicer	
2	1.7	Optical Sources and Detectors	10
-	2.1	Coherent and non-coherent sources, quantum efficiency, modulation capability of	
	2.1	optical sources	
	2.2	LEDs: Working principle and characteristics	-
	2.3	Laser diodes: Working principle and characteristics	-
	2.4	Working principle and characteristics of detectors: PIN and APD, noise analysis in	
		detectors, coherent and non-coherent detection, receiver structure, bit error rate of	
		optical receivers, and receiver performance	
3		Components of Optical Fiber Networks	08
-	3.1	Overview of fiber optic networks, trans-receiver, semiconductor optical amplifiers	
	3.2	Couplers/splicer, wavelength division multiplexers and de-multiplexers	
	3.3	Filters, isolators and optical switches	
4		Transmission Characteristic of Optical Fiber	08
	4.1	Attenuation, absorption, linear and nonlinear scattering losses, bending losses, modal	
		dispersion, waveguide dispersion and pulse broadening,	
	4.2	Dispersion shifted and dispersion flattened fibers, and non linear effects	
	4.3	Measurement of optical parameters, attenuation and dispersion, OTDR	
5		Optical Networks	08
	5.1	SONET and SDH standards, architecture of optical transport networks (OTNs),	1
		network topologies	
	5.2	Operational principle of WDM, WDM network elements and Architectures,	
		Introduction to DWDM, Solitons.	
6		Network Design and Management	08
	6.1	Point to point links system considerations, link power budget, and rise time budget	1
	6.2	Transmission system model, power penalty-transmitter, receiver optical amplifiers, crosstalk, dispersion, wavelength stabilization.	
	6.3	Network management functions, configuration management, performance	
	0.5	management, fault management, optical safety and service interface	
		Total	52

2

- 1. John M. Senior, "*Optical Fiber Communication*", Prentice Hall of India Publication, Chicago, 3<sup>rd</sup> Edition, 2013
- 2. Gred Keiser, "Optical Fiber Communication", Mc-Graw Hill Publication , Singapore, 4<sup>th</sup> Edition, 2012
- 3. G Agarwal, "Fiber Optic Communication Systems", John Wiley and Sons, 3<sup>rd</sup> Edition, New York 2014
- 4. S.C. Gupta, "*Optoelectronic Devices and Systems*", Prentice Hall of India Publication, Chicago, 2005.

#### **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining question will be selected from all the modules.

Course Code	Course Name	Te	aching Sch	eme	Credits Assigned				
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total	
EXL701	Embedded		02			01		01	
	System Design Laboratory								

Course	Course				me			
Code	Name			Theory Mar	Term Work	Oral	Total	
		Internal assessment End Sem. Exam						
		Test	Test	Ave. Of				
		1	2	Test 1 and				
				Test 2				
EXL701	Embedded					25	25	50
	System							
	Design					5		
	Laboratory							

At least 10 experiments based on the entire syllabus of Subject **EXC701** should be set to have well predefined inference and conclusion. Computation/simulation based experiments are encouraged. The attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the **overall performance** of the student with **every experiment graded from time to time**. The grades should be converted into marks as per the **Credit and Grading System** manual and should be **added and averaged**. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work.

Course Code	Course Name	Te	aching Sch	eme	Credits Assigned			
Course Coue		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total
EXL702	IC Technology Laboratory		02			01		01

Course	Course Name				Examination Sc	cheme				
Code				<b>Theory Marks</b>	Term Work	Oral	Total			
		In	ternal a	ssessment	End Sem.					
		Test	Test	Ave. Of	Exam					
		1	2	Test 1 and						
				Test 2						
<b>EXL702</b>	IC Technology					25	25	50		
	Laboratory									

At least 10 experiments based on the entire syllabus of Subject **EXC702** should be set to have well predefined inference and conclusion. Computation/simulation based experiments are encouraged. The attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the **overall performance** of the student with **every experiment graded from time to time**. The grades should be converted into marks as per the **Credit and Grading System** manual and should be **added and averaged**. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work.

Course Code	Course Name	Te	aching Sch	eme	Credits Assigned				
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total	
EXL703	Power		02			01		01	
	Electronics –II								
	Laboratory								

Course	Course Name		Examination Scheme								
Code				Theory Ma	rks	Term	Oral	Total			
		Internal assessment			End Sem. Exam	Work					
		Test Test Ave. Of									
		1	2	Test 1 and							
				Test 2							
EXL703	Power					25	25	50			
	Electronics –II										
	Laboratory						•				

At least 10 experiments based on the entire syllabus of Subject **EXC703** should be set to have well predefined inference and conclusion. Computation/simulation based experiments are encouraged. The attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the **overall performance** of the student with **every experiment graded from time to time**. The grades should be converted into marks as per the **Credit and Grading System** manual and should be **added and averaged**. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work.

Course	Course Name	<b>Teaching Scheme</b>	Credits Assigned

Code								
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total
<b>EXL704</b>	Computer		02			01		01
	Communication							
	Networks							
	Laboratory							

Course	Course Name		Examination Scheme						
Code				Theory Ma	rks	Term	Oral	Total	
		Internal assessment			End Sem. Exam	Work			
		Test	Test	Ave. Of					
		1	2	Test 1 and					
				Test 2					
EXL704	Computer					25	25	50	
	Communication								
	Networks								
	Laboratory								

At least 10 experiments based on the entire syllabus of Subject **EXC704** should be set to have well predefined inference and conclusion. Computation/simulation based experiments are encouraged. The attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the **overall performance** of the student with **every experiment graded from time to time**. The grades should be converted into marks as per the **Credit and Grading System** manual and should be **added and averaged**. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work.

Course Code	Course Name	Teaching Scheme			Credits Assigned			
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total
EXL705X	Elective I		02			01		01
	Laboratory							

Course	Course	Examination Scheme								
Code	Name			Theory Mai	rks	Term	Oral	Total		
		Int	ernal as	ssessment	End Sem. Exam	Work				
		Test	Test	Ave. Of						
		1	2	Test 1 and						
				Test 2						
EXL705X	Elective I					25	25	50		
	Laboratory									

At least 10 experiments based on the entire syllabus of Subject **EXC705X** should be set to have well predefined inference and conclusion. Computation/simulation based experiments are encouraged. The attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the **overall performance** of the student with **every experiment graded from time to time**. The grades should be converted into marks as per the **Credit and Grading System** manual and should be **added and averaged**. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work.

Practical and oral exam will be based on the entire syllabus of EXC705X

#### Elective – I

Code	Name of Elective					
EXC7051	Digital Image Processing					
EXC7052	Artificial Intelligence					
EXC7053	ASIC Verification					
EXC7054	Optical Fiber Communication					

Course Code	Course Name	Teaching Scheme			Credits Assigned				
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total	
EXC706	Project - I)		02			01		01	

Course	Course Name		Examination Scheme								
Code				<b>Theory Ma</b>	rks	Term	Practical	Oral	Total		
		Inte	Internal assessment		End Sem.	Work					
		Test	Test	Ave. Of	Exam						
		1	2	Test 1							
				and Test							
				2							
EXc706	Project -I					25	-	25	50		

The final year students have already under gone project assignment in their pre-final year in Mini Project I and II. In final year group of maximum **four** students will be completing a comprehensive project work based on the courses studied. The project work may be internally assigned or may be externally assigned by the research institutes, industry etc. Each group will be assigned one faculty as a supervisor. This project work in final year may be extension of the Mini Project work done in pre-final year.

The main intention of Project work is to enable students to apply the knowledge and skills learned out of courses studied to solve/implement predefined practical problem. The Project work may be beyond the scope of curriculum of courses taken or may be based on the courses but thrust should be

- Learning additional skills
- Development of ability to define, design, analysis and implementation of the problem and lead to its accomplishment with proper planning
- Learn the behavioral science by working in a group
- The project area may be selected in which the student intend to do further education and/or may be either intend to have employment or self employment
- The topic of project should be different and / or may be advancement in the same topic of Mini Project
- The students may use this opportunity to learn different computational techniques as well as some model development. This they can achieve by making proper selection of Project work.

The college should keep proper assessment record of the progress of project and at the end of the semester it should be assessed for awarding TW marks. The TW should be examined by approved internal faculty appointed by the head of the institute on the basis of following:

- Scope and objective of the project work.
- Extensive Literature survey.
- Progress of the work (Continuous assessment)
- Report in prescribed University format.

An approved external examiner and internal examiner appointed by the head of the institute together will assess during oral examination. The oral examination is a presentation by the group members on the project along with demonstration of the work done. In the examination each individual student should be assessed for his/her contribution, understanding and knowledge gained.

Subject Code     Subject     Teaching Scheme	Credits Assigned
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	Name							
		Theory	Practical	Tutorial	Theory	<b>TW/Practical</b>	Tutorial	Total
EXC801	CMOS VLSI Design	04	-		04			04

Subject	Subject		Examination Scheme									
Code	Name			Theory Mar	·ks	Term	Practical	Oral	Total			
		Int	ernal as	ssessment	End Sem.	Work						
		Test	Test	Avg. of	Exam							
		1	2	Test 1 and								
				Test 2								
EXC801	CMOS	20	20	20	80				100			
	VLSI Design											

# **Course Pre-requisite:**

- EXC302: Electronic Devices
- EXC303: Digital Circuits and Design
- EXC402: Discrete Electronic Circuits
- EXC502: Design With Linear Integrated Circuits
- EXC601: VLSI Design
- EXC702: IC Technology

#### **Course Objectives:**

- 1. To teach analysis and design of building blocks of CMOS Analog VLSI Circuits.
- 2. To highlight the issues associated with the CMOS analog VLSI circuit design.

### **Course Outcomes:**

# After successful completion of the course student will be able to

- 1. discuss tradeoffs involved in analog VLSI Circuits.
- 2. analyze building blocks of CMOS analog VLSI circuits.
- 3. design building blocks of CMOS analog VLSI circuits
- 4. carry out verifications of issues involved in analog circuits via simulations

1.0	No.		
1.0		CMOS analog building blocks	8
	1.1	MOS Models: Necessity of CMOS analog design, Review of characteristics of	
		MOS device, MOS small signal model, MOS spice models	
	1.2	Passive and Active Current Mirrors: Basic current mirrors, Cascode current	
		mirrors and Active current mirrors	
	1.3	Band Gap References: General Considerations, Supply-independent biasing,	
		Temperature independent references, PTAT current generation and Constant Gm	
		biasing	
2.0		Single Stage Amplifiers	10
	2.1	Configurations: Basic concepts, Common source stage, Source follower, Common	
		gate stage, Cascode stage	
	2.2	Frequency Response and Noise: General considerations, Common-source stage,	
		Source followers, Common-gate stage, Cascode stage and Noise in single stage	
		amplifiers	
3.0		Differential Amplifiers	10
	3.1	<b>Configurations:</b> Single ended and differential operation, Basic differential pair,	
		Common-mode response, Differential pair with MOS loads, Gilbert cell	
	3.2	Frequency response and noise in differential pair	
4.0		MOS Operational Amplifiers	10
	4.1	<b>Op-amp Design:</b> General Considerations, performance parameters, One-stage op-	
		amps, Two-stage op-amps, Gain Boosting, Common-mode feedback, Input range	
		limitations, Slew Rate, Power supply rejection, Noise in op-amps	
	4.2	Stability and Frequency Compensation: General Considerations, Multipole	
		systems, Phase margin, Frequency compensation, compensation of two stage op-	
		amps	
5.0		Mixed Signal Circuits	10
	5.1	Switch Capacitor Circuits: MOSFETs as switches, Speed considerations,	
		Precision Considerations, Charge injection cancellation, Unity gain buffer, Non-	
		inverting amplifier and integrator	
	5.2	Oscillators: General considerations, Ring oscillators, LC oscillators, VCO	
	5.3	Phase-Locked Loop: Simple PLL, Charge pump PLL, Nonideal effects in PLL,	
		Delay locked loops and applications of PLL in integrated circuits	
6.0		Analog Layout and other concepts	04
	6.1	Analog Layout Techniques: Antenna effect, Resistor matching, capacitor	
		matching, current mirror matching, floorplanning, shielding and guard rings	
	6.2	matching, current mirror matching, floorplanning, shielding and guard rings AMS design flow, ASIC, Full custom design, Semi custom design, System on Chip,	
	6.2	AMS design flow, ASIC, Full custom design, Semi custom design, System on Chip, System in package, Hardware software co-design	

- 1. B Razavi, "Design of Analog CMOS Integrated Circuits", Tata McGraw Hill, 1<sup>st</sup> Edition.
- 2. R. Jacaob Baker, Harry W. Li, David E. Boyce, "CMOS Circuit Design, Layout, and Stimulation", Wiley, Student Edition
- 3. P. E. Allen and D. R. Holberg, "*CMOS Analog Circuit Design*", Oxford University Press, 3<sup>rd</sup> Edition.
- 4. Gray, Meyer, Lewis, Hurst, "Analysis and design of Analog Integrated Circuits", Willey, 5<sup>th</sup> Edition

# **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining questions will be selected from all the modules

Code								
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total
EXC 802	Advanced Networking Technologies	04			04			04

Course	Course Name	Examination Scheme							
Code			The	eory Marks		Term	Practical	Oral	Total
		Internal assessment			End	Work			
		Test 1	Test 2	Ave. Of Test 1 and Test 2	Sem. Exam			C	
EXC 802	Advanced Networking Technologies	20	20	20	80	-	- (	5	100

# **Course Pre-requisite:**

• EXE704: Computer Communication Networks

# **Course Objectives:**

- 1. To make students familiar with data communication technologies and how to use them to: Design, Implement, Operate, Manage enterprise networks.
- 2. To introduce the concept of wireless WAN, WAP and different IEEE standards.

# **Course Outcomes:**

# Upon completion of the course, students should be able to:

- 1. Analyze the performance of networks.
- 2. Determine the network performance using monitor tools..
- 3. Set up WLAN, PAN
- 4.Explain optical networking technology

Module	Unit	Iodule     Unit     Topics	Hrs.
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4.0		No.	No.
10	Emerging Wireless Technologies		1
	Wireless Personal Area Network – Bluetooth Bluetooth (IEEE	1.1	
	802.15.1), Definitions of the Terms Used in Bluetooth, Bluetooth		
	Protocol Stack, Bluetooth Link Types, Bluetooth Security, Network		
	Connection Establishment in Bluetooth, Network Topology in		
	Bluetooth, Bluetooth Usage Models		
	Bluetooth Applications, WAP and Bluetooth Wireless Personal Area	1.2	
	Networks (WPAN):Low Rate (LR) and High Rate (HR)Wireless		
	Sensor Network, Usage of Wireless Sensor Networks, Wireless		
	Sensor Network		
		1.3	
	Model, Sensor Network Protocol Stack, ZigBee Technology, IEEE	1.5	
	802.15.4 LR-WPAN Device Architecture, IEEE 802.15.3a Ultra		
	WideBand, Radio Frequency Identification.		
06	Optical Networking		2
	ONET/SDH Standards, devices, DWDM, frame format, DWDM,	2.1	
	Performance and design considerations.		
12	WAN Technologies		3
	Frame: FR concept, FR specifications, FR design and VoFR and	3.1	
	Performance and design considerations		
	ATM: The WAN Protocol: Faces of ATM, ATM Protocol	3.2	
	operations. (ATM cell and Transmission) ATM Networking basics,	0.2	
	Theory of Operations, B-ISDN reference model, PHY layer, ATM		
	Layer (Protocol model), ATM layer and cell		
		3.3	
	Traffic Descriptor and parameters, Traffic Congestion control	5.5	
	defined, AAL Protocol model, Traffic contract and QoS, User Plane		
	overview, Control Plane AAL, Management Plane, Sub S3		
00	ATM,ATM public services		
08	Network Design		4
	Network layer design, access layer design, access network capacity,	4.1	
	network topology and Hardware and completing the access network		
	design.		
08	Network Security		5
	Security threats, safeguards and design for network security	5.1	
	Enterprise Network Security: DMZ, NAT, SNAT, DNAT, Port	5.2	
	Forwarding, Proxy, Transparent Proxy, Packet Filtering and Layer 7		
	Filtering		
	Network Management and Control		6
08	Network management definitions, functional areas (FCAPS), SNMP,	6.1	
- 0	RMON,		
	Designing a network management solutions, Monitoring and control	6.2	
	of network activity and network project management		
52	Total		

- 1. Data Network Design by Darren Spohn, 3e McGraw Hill publications
- 2. Data Communication and Network Security by Carr and Snyder, McGraw Hill Publications.
- 3. Communication Networks by Leon-Garcia and Indra Widjaja, 2e, Tata McGraw-Hill Publications.
- 4. Information Security by Mark Stamp and Deven Shah by Wiley Publications.
- 5. Behrouz A Forouzan, Data communications and Networking 4<sup>th</sup> Edition,
- 6. McGraw-Hill Publication.
- 7. William Stallings, Data Computer Communications, Pearson Education
- 8. Wireless communication and Networking-Vijay Garg, ELSEVIER Inc.
- 9. Eldad Perahita ,Next Generation wireless LANS, Cambridge Publication
- 10. Computer Networking by J. F. Kurose and K. W. Ross, Pearson Education
- 11. Local Area Networks by Gerd Keiser, McGraw-Hill Publication.

#### **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining questions will be selected from all the modules

Subject Code	Course Name	Teaching Scheme	Credits Assigned						
		Theory	PracticalTutorialTheoryTW/TutorialTotalPracticalPractical						
EXC803	MEMS Technology	04			04			04	

Subject	Subject Name		Examination Scheme								
Code				<b>Theory Mar</b>	ks	Term	Practical	Oral	Total		
		Int	ernal as	ssessment	End Sem.	Work					
		Test	Test	Ave. Of	Exam						
		1	2	Test 1 and							
				Test 2							
EXC803	MEMS	20	20	20	80	-	-	_	100		
	Technology						Co	•			

# **Course Pre – requisite:**

- EXC 404: Basic VLSI Design
- EXC 604: IC Technology

# **Course Objective:**

- To provide a basic knowledge of MEMS processing steps and processing modules.
- To demonstrate the use of semiconductor based processing modules used in the fabrication of variety of sensors and actuators (e.g. pressure sensors, accelerometers, etc.) at the micro-scale.
- To provide an understanding of basic design and operation of MEMS sensors and transducers.

# **Course Outcome:**

# On Completion of this course Student will be able to

- Understand the underlying fundamental principles of MEMS devices including physical operation, mathematical modeling and fabrication.
- Design and simulate MEMS devices and system using standard simulation tools.
- Develop different concepts of micro system sensors and actuators for real-world applications.

Module	Unit	Topics	Hrs.
No.	No.		
1.		Introduction to MEMS	04
	1.1	Introduction to MEMS & Real world Sensor/Actuator examples (DMD, Air-bag,	
		pressure sensors). MEMS Sensors in Internet of Things (IoT), BioMedical	
		Applications	
2		MEMS Materials and Their Properties	10
	2.1	Materials (eg. Si, SiO2, SiN, Cr, Au, Ti, SU8, PMMA, Pt); Important properties:	
		Young modulus, Poisson's ratio, density, piezoresistive coefficients, TCR, Thermal	
		Conductivity, Material Structure. Understanding Selection of materials based on	
		applications.	
3		MEMS Fab Processes – 1	11
	3.1	Understanding MEMS Processes & Process parameters for: Cleaning, Growth &	
		Deposition, Ion Implantation & Diffusion, Annealing, Lithography. Understanding	
		selection of Fab processes based on Applications	
4		MEMS Fab Processes – 2	10
	4.1	Understanding MEMS Processes & Process parameters for: Wet & Dry etching, Bulk	
		& Surface Micromachining, Die, Wire & Wafer Bonding, Dicing, Packaging.	
		Understanding selection of Fab processes based on Applications	
5		MEMS Devices	11
	5.1	Architecture, working and basic quantitative behaviour of Cantilevers, Microheaters,	
		Accelerometers, Pressure Sensors, Micromirrors in DMD, Inkjet printer-head.	
		Understanding steps involved in Fabricating above devices	
6		MEMS Device Characterization	06
	6.1	Piezoresistance, TCR, Stiffness, Adhesion, Vibration, Resonant frequency, &	
		importance of these measurements in studying device behavior, MEMS Reliability	
	1	Total	52

- 1. An Introduction to Microelectromechanical Systems Engineering; 2<sup>nd</sup> Ed by N. Maluf, K Williams; Publisher: Artech House Inc
- 2. Practical MEMS by Ville Kaajakari; Publisher: Small Gear Publishing
- 3. Microsystem Design by S. Senturia; Publisher: Springer
- 4. Analysis and Design Principles of MEMS Devices Minhang Bao; Publisher: Elsevier Science
- 5. Fundamentals of Microfabrication by M. Madou; Publisher: CRC Press; 2 edition
- 6. Micro Electro Mechanical System Design by J. Allen; Publisher: CRC Press
- 7. Micromachined Transducers Sourcebook by G. Kovacs; Publisher: McGraw-Hill

#### **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining questions will be selected from all the modules

Subject Code	Subject Name	Teaching Scheme			Credits Assigned				
		Theory	Practical	Tutorial	Theory	<b>TW/Practical</b>	Tutorial	Total	
EXC8041	Robotics	04			04			04	

Subject	Subject	Examination Scheme								
Code	Name			<b>Theory Mar</b>	·ks	Term	Practical	Oral	Total	
		Int	ernal as	ssessment	End Sem.	Work				
		Test	Test	Avg. of	Exam					
		1	2	Test 1 and						
				Test 2						
EXC8041	Robotics	20	20	20	80				100	

# **Course Pre-requisite:**

- EXS 301 : Applied Mathematics III
- EXS 401 : Applied Mathematics IV
- EXC 404 : Principles of Control Systems

# **Course Objectives:**

- 1. To prepare students with basics of robotics
- 2. To familiarize students with kinematics & dynamics of robots
- 3. To familiarize students with path & Trajectory planning of robots
- 4. To familiarize students with robot vision

# **Course Outcomes:**

# After successful completion of the course student will be able to

- 1. Describe kinematics and dynamics of stationary and mobile robots
- 2. Describe trajectory planning for robots
- 3. Implement trajectory generation and path planning various algorithms
- 4. Work in interdisciplinary projects

Module No.	Unit No.	Topics	Hrs.
1	110.	Fundamentals of Robotics	03
-	1.1	Robot Classification, Robot Components, Degrees of freedom, Joints, Coordinates,	00
		Coordinate frames, workspace, applications	
2		Forward & Inverse Kinematics of Robots	09
_	2.1	Homogeneous transformation matrices, Inverse transformation matrices, Forward	
		and inverse kinematic equations – position and orientation	
	2.2	Denavit-Hatenberg representation of forward kinematics, Inverse kinematic	
		solutions, Case studies	
3		Velocity Kinematics & Dynamics	14
	3.1	Differential motions and velocities : Differential relationship, Jacobian,	
		Differential motion of a frame and robot, Inverse Jacobian, Singularities.	
	3.2	Dynamic Analysis of Forces : Lagrangian mechanics, Newton Euler formulation,	
		Dynamic equations of robots, Transformation of forces and moment between	
		coordinate frames	
4		Robot Motion Planning	04
	4.1	Concept of motion planning, Bug Algorithms – Bug1, Bug2, Tangent Bug	
5		Potential Functions and Visibility Graphs	08
	5.1	Attractive/Repulsive potential, Gradient descent, wave-front planner, navigation	
		potential functions, Visibility map, Generalized Voronoi diagrams and graphs,	
		Silhouette methods	
6		Trajectory planning	08
	6.1	Trajectory planning, Joint-space trajectory planning, Cartesian-space trajectories	
7		Robot Vision	06
	7.1	Image representation, Template matching, Polyhedral objects, Shape analysis,	
		Segmentation, Iterative processing, Perspective transform.	
		Total	52

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- 1. Robert Shilling, Fundamentals of Robotics Analysis and control, Prentice Hall of India
- 2. Saeed Benjamin Niku, "Introduction to Robotics Analysis, Control, Applications", Wiley India Pvt. Ltd., Second Edition, 2011
- 3. Howie Choset, Kevin M. Lynch, Seth Hutchinson, George Kantor, Wolfram Burgard, Lydia E. Kavraki and Sebastian Thrun, "Principles of Robot Motion Theory, Algorithms and Implementations", Prentice-Hall of India, 2005.
- 4. Mark W. Spong , Seth Hutchinson, M. Vidyasagar, "Robot Modeling & Control ", Wiley India Pvt. Ltd., 2006
- 5. John J. Craig, "Introduction to Robotics Mechanics & Control", Third Edition, Pearson Education, India, 2009
- 6. Aaron Martinez & Enrique Fernandez, "Learning ROS for Robotics Programming", Shroff Publishers, First Edition, 2013.
- 7. Mikell P. Groover et.al, "Industrial Robots-Technology, Programming & applications", McGraw Hill, New York, 2008

# **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining questions will be selected from all the modules

Subject Code	Subject Name	Teach	ing Scheme	e (Hrs.)	Credits Assigned					
		Theory	Practical	Tutorial	Theory	<b>TW/Practical</b>	Tutorial	Total		
EXC 8042	Mobile Communication	04			04			04		

Subject	Subject Name				Examination	on Scheme					
Code			T	heory Marks		Term	Practical	Oral	Total		
		Internal assessment End Sem. V									
		Test 1	Test	Ave. Of	Exam						
			2	Test 1 and							
				Test 2							
EXC 8042	Mobile	20	20	20	80		(	1	100		
	Communication										

#### **Course Pre-requisite:**

- EXC 704: Computer Communication Networks
- EXC: Digital Communication

# **Course Objectives:**

To enable the student to study, understand and appreciate the concepts of mobile communication technology. **Course Outcomes:** 

# After successful completion of the course student will be able to

- 1. Understand the fundamentals of mobile communications
- 2. Differentiate between GSM and CDMA
- 3. Understand the evolving wireless communication technologies.
- 4. Understand the requirement of 4 G technology

Module No.	Unit No.	Topics	Hrs.
1	1100	Cellular Communication System	10
	1.1	Introduction to Cellular Communications, Frequency reuse, Multiple Access	
		Technologies	
	1.2	Cellular Processes: Channel assignment, Call Setup, Handoff strategies,	
		interferences and system capacity	
	1.3	<b>Traffic Theory:</b> Trunking and grade of service, improving system capacity	
2		GSM	8
	2.1	GSM Network architecture, signaling protocol architecture, identifiers,	
		channels, Frame structure, speech coding, authentication and security, call	
		procedure, handoff procedure, services and features	
3		CDMA digital cellular standard (18-95).	8
	3.1	Frequency and channel specifications of IS-95, forward and reverse CDMA	
		channel, packet and frame formats, mobility and radio resource management	
4		3 G Mobile Communication System	10
	4.1	2.5 G TDMA Evolution Path, GPRS, EDGE, 2.5G CDMA one cellular N/W,	
		Need of 3G Cellular N/w, IMT 2000 Global Standard, UMTS Technology,	
		W-CDMA Air interface, TD-SCDMA Technology, CDMA 2000 Cellular	
		Technology	
5		4G Wireless Standards	8
	5.1	Need for 4G network, difference between 3G and 4G, LTE, WiMAX	
6		Emerging Technologies	8
	6.1	Mobile Adhoc Network, Mobile IP and Mobility Management, Mobile TCP,	
		Wireless Sensor Networks, RFID Technology	
		Total	52

300

- 1. Wireless Communications Theodore S. Rappaport, Prentice Hall of India, PTR publication
- 2. Mobile & Personal Communication system & Services by Raj Pandya , Prentice –Hall of India (PHI) Private Limited
- 3. Principles of Wireless Networks-KavehPahlavan, Prashant Krishnamurthy, PHI
- 4. Wireless communication and Networking-Vijay Garg, ELSEVIER Inc
- 5. Wireless communication- Singhal\_TMH
- 6. Fundamentals of Wireless Communications, "David Tse and Pramod Viswanath, Publisher, Cambridge University Press.
- 7. Wireless Communications: Andrea Goldsmith, Cambridge University Press.

# **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining questions will be selected from all the modules

Subject Code	Subject Name	Teach	ing Scheme	e (Hrs.)	Credits Assigned				
		Theory	Practical	Tutorial	Theory	<b>TW/Practical</b>	Tutorial	Total	
EXC 8043	Digital Control System	04			04			04	

Subject	Subject	Examination Scheme								
Code	Name		Т	heory Marks	Term	Practical	Oral	Total		
		Inte	rnal as	ssessment	End Sem.	Work				
		Test 1	Test	Ave. Of	Exam					
			2	Test 1 and						
				Test 2						
EXC 8043	Digital	20	20	20	80		-	1	100	
	Control									
	System									

# **Course Prerequisites:**

- EXC404: Principles of Control System
- EXC504: Signals and Systems

#### **Course Objective:**

- 1. To study the importance of digital control
- 2. To study stability analysis of digital control systems
- 3. To study the design of digital control systems

# **Course Outcomes:**

- 1. Students will be able to differentiate between analog and digital control and importance of digital control
- 2. Student will be able to analyze the digital control systems
- 3. Students will be able to design digital controllers

Module No.	Unit No.	Topics	Hrs.							
1.0		Introduction								
	1.1	Why digital control system? Advantages and limitations, comparison of continuous	12							
		and discrete data control, block diagram of digital control system								
	1.2	Data conversion and quantization, sampling and reconstruction of analog signal, zero								
		and first order hold								
	1.3	Impulse invariance, bilinear transformation, finite difference approximation of								
		derivatives								
2.0		Modeling of Digital Control System	04							
	2.1	Linear difference equation, pulse transfer function, input output model								
	2.2	Examples of first order continuous and discrete time systems								
	2.3	Signal flow graph applied to digital control system								
3.0		Time Domain Analysis and Stability of Digital Control System	08							
	3.1	Mapping between s plane and Z plane, Jury's method, R. H. criteria								
	3.2	Comparison of time response of continuous and digital control system								
	3.3	Steady state analysis of digital control system, effect of sampling on transient								
		response								
4.0		State Space Analysis	08							
	4.1	Discrete time state equation in standard canonical form, similarity transformation								
	4.2	State transition matrix, solution of discrete time state equation								
	4.3	Discretization of continuous state space model and its solution.								
5.0		Pole Placement and Observer Design	10							
	5.1	Concept of reachability, controllability, constructability and observability								
	5.2	Design of controller using pole placement method, dead beat controller design								
	5.3	Concept of duality, state observer design, concept of multi rate output feedback based								
		state estimation								
6.0		Transfer Function Approach to Controller Design	10							
	6.1	Control structures, internal stability,								
	6.2	Internal model principle and system type, well behaved signals								
	6.3	Discretization of PID controllers, pole placement controllers with performance specifications								
		Total	52							

- 1. M. Gopal, "Digital Control and State Variable Methods", McGraw Hill companies, 3<sup>rd</sup> edition, 2009.
- 2. K. Ogata, "Discrete-Time Control Systems", PHI, 2<sup>nd</sup> edition, 2009.
- 3. B. C. Kuo, "Digital Control Systems", Oxford University press, 2<sup>nd</sup> edition, 2007.
- 4. K. M. Moudgalya, "Digital Control", Wiley India, 2012.

### **Internal Assessment (IA):**

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining questions will be selected from all the modules

Course ande	Course Name	Teaching	Scheme (Hrs	Credit Assigned				
Course code		Theory	Practical	Tutorial	Theory	Practical	Tut.	Total
EXC8044	Biomedical Electronics	4						4

Course	Course Name		Examination Scheme							
code		]	Theory (or	ut of 100)		Term	Practical	Oral	Total	
		Internal	l Assessme	ent (out	End	Work	and			
			of 20)		Sem.		oral			
		Test 1 Test 2 Avg.			Exam					
EXC8044	Biomedical	20	20	20	80				150	
LAC0044	Electronics	20	20	20	80				130	

# **Course Pre-requisites**:

- EXC305:Electronic Instruments and Measurements
- FEC102,202: Applied Physics I and II

# **Course Objective:**

- 1. To make students understand the Identification, classification, and working principle of various Biomedical Instruments used for Bio-potential measurement
- 2. Application of these instruments in diagnosis, therapeutic treatment and imaging fields

#### **Course Outcome:**

The Students will be able to

- 1. Identify various Bio-potential and their specifications in terms of amplitude and frequency.
- 2. Understand principle and working of various Biomedical Instruments for diagnosis applications.
- 3. Decide the applications of therapeutic instruments for treatment purpose.
- 4. Understand applications of imaging instruments and the modalities involved in each technique.

Unit No.	Topics	Hr
110.	Bio-Potential and Measurement	0
11		U
1,1		
1.2		
		1
2.1	Respiratory system- Physiology of respiration and measurements of	
	respiratory related parameters	
2.2	Cardiovascular system- Structure of Heart, Electrical and Mechanical	
	activity of Heart, ECG measurements and Cardiac arrhythmias	
2.3	Nervous system- Nerve cell, neuronal communication, nerve-muscle	
	physiology, CNS, PNS. Generation of EEG and its measurement. Normal	
2.4	Muscular system- Generation of EMG signal, specification and	
	measurement.	
		0
3.1		
	-	
		0
4 1		0
4.1		
		1
5.1		-
0.1		
5.2		
5.3		
		0
6.1	Physiological effects of electrical current, Shock Hazards from electrical	Ū
0.1	equipments and methods of accident prevention.	
	1.1     1.2     2.1     2.2     2.3     2.4     3.1     4.1     5.1     5.2     5.3	Bio-Potential and Measurement       1.1     Structure of Cell, Origin of Bio-potential, electrical activity of cell their characteristic and specifications.       1.2     Measurement of RMP and AP. Electrode-Electrolyte interface and types of bio-potential electrodes.       Physiological Systems and Related Measurement     1.1       2.1     Respiratory system- Physiology of respiration and measurements of respiratory related parameters       2.2     Cardiovascular system- Structure of Heart, Electrical and Mechanical activity of Heart, ECG measurements and Cardiac arrhythmias       2.3     Nervous system- Nerve cell, neuronal communication, nerve-muscle physiology, CNS, PNS. Generation of EEG and its measurement. Normal and abnormal EEG, evoked potential and epilepsy       2.4     Muscular system- Generation of EMG signal, specification and measurement.       Design of ECG amplifier     Cardiovascular Measurement       3.1     Blood Pressure- Direct and Indirect types.       Blood Flow- Electromagnetic and Ultrasonic types.     Blood Volume- Types of Plethysmography. (Impedance, Capacitive and Photoelectric)       Cardiac Output- Flicks method, Dye-dilution and Thermo-dilution type. Heart sound measurement     Life support Instruments       4.1     Pacemaker- Types of Pacemaker, mode of pacing and its application. Heart Lung machine and its application during surgery. Haemodialysis system and the precautions to be taken during dialysis. Baby Incubator and its application </td

- 1. Leslie Cromwell, "Biomedical Instrumentation and Measurements", 2<sup>nd</sup> Edition, Pearson Education, 1980.
- 2. John G. Webster, "Medical Instrumentation", John Wiley and Sons, 4<sup>th</sup> edition, 2010.
- 3. R. S. Khandpur, "Biomedical Instrumentation", TMH, 2004
- 4. Richard Aston, "Principles of Biomedical Instrumentation and Instruments", PH, 1991.
- 5. Joseph J. Carr and John M. Brown, "Introduction to Biomedical Equipment Technology", PHI/Pearson Education, 4<sup>th</sup> edition, 2001.
- 6. John E Hall, Gyton's Medical Physiology, 12th edition, 2011

# Internal Assessment (IA):

Two tests must be conducted which should cover at least 80% of syllabus. The average marks of both the test will be considered as final IA marks

- 1. Question paper will comprise of 6 questions, each of 20 marks.
- 2. Total 4 questions need to be solved.
- 3. Question No.1 will be compulsory and based on entire syllabus wherein sub questions of 2 to 5 marks will be asked.
- 4. Remaining questions will be selected from all the modules

Course Code	Course Name	Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total
EXL 801	CMOS VLSI		02			01		01
	Design							
	Laboratory							

Cours	e Course		Examination Scheme								
Code	e Name			Theory Marks		Term	Practical	Oral	Total		
			Interna	l assessment	End Sem.	Work	and				
		Test	Test	Ave. Of Test 1	Exam		Oral				
		1	2	and Test 2							
EXL80	D1 CMOS					25		25	50		
	VLSI										
	Design										
	Laboratory						.Co	•			

At least 10 experiments based on the entire syllabus of Subject **EXC801** should be set to have well predefined inference and conclusion. Computation/simulation based experiments are encouraged. The attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the **overall performance** of the student with **every experiment graded from time to time**. The grades should be converted into marks as per the **Credit and Grading System** manual and should be **added and averaged**. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work.

**Practical and oral exam** will be based on the entire syllabus of **EXC801**.

<b>Course Code</b>	Course Name	Te	aching Sch	eme	Credits Assigned				
		Theory	Practical	Tutorial	Total				
EXL 802	Advanced		02			01		01	
	Networking								
	Technologies								
	Laboratory								

Course	Course Name		Examination Scheme								
Code				Theory Marks		Term	Practical	Oral	Total		
			Internal	assessment	End Sem.	Work	and				
		Test	Test 2	Ave. Of Test 1	Exam		Oral				
		1		and Test 2							
EXL802	Advanced					25		25	50		
	Networking										
	Technologies										
	Laboratory										

At least 10 experiments based on the entire syllabus of Subject **EXC802** should be set to have well predefined inference and conclusion. Computation/simulation based experiments are encouraged. The attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the **overall performance** of the student with **every experiment graded from time to time**. The grades should be converted into marks as per the **Credit and Grading System** manual and should be **added and averaged**. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work.

**Practical and oral exam** will be based on the entire syllabus of **EXC802**.

Course Code	Course Name	Te	aching Sch	eme	Credits Assigned				
		Theory	Theory Practical Tutorial Theory Practical Tutorial						
EXL 803	MEMS		02			01		01	
	Technology								
	Laboratory								

Course	Course Name		Examination Scheme							
Code			]	<b>Fheory Marks</b>	Term	Practical	Oral	Total		
		Iı	nternal	assessment	Work	and				
		Test	Test	Ave. Of Test		Oral				
		1	2	1 and Test 2	Exam					
EXL803	MEMS					25		25	50	
	Technology									
	Laboratory									

At least 10 experiments based on the entire syllabus of Subject **EXC803** should be set to have well predefined inference and conclusion. Computation/simulation based experiments are encouraged. The attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the **overall performance** of the student with **every experiment graded from time to time**. The grades should be converted into marks as per the **Credit and Grading System** manual and should be **added and averaged**. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work.

**Practical and oral exam** will be based on the entire syllabus of **EXC803**.

<b>Course Code</b>	Course Name	Те	aching Sch	eme	Credits Assigned				
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total	
EXL 804X	Elective –II		02			01		01	
	Laboratory								

Course	Course Name		Examination Scheme						
Code				<b>Theory Marks</b>	Term	Practical	Oral	Total	
		Iı	nternal	assessment	Work	and			
		Test	Test Test Ave. Of Test 1 Exam				Oral		
		1	2	and Test 2					
EXL	Elective –II					25		25	50
804X	Laboratory								

At least 10 experiments based on the entire syllabus of Subject **EXE804X** should be set to have well predefined inference and conclusion. Computation/simulation based experiments are encouraged. The attempt should be made to make experiments more meaningful, interesting and innovative. Term work assessment must be based on the **overall performance** of the student with **every experiment graded from time to time**. The grades should be converted into marks as per the **Credit and Grading System** manual and should be **added and averaged**. The grading and term work assessment should be done based on this scheme.

The final certification and acceptance of term work ensures satisfactory performance of laboratory work and minimum passing marks in term work.

Practical and oral exam will be based on the entire syllabus of EXE804X.

#### **Elective** –**II**

Code	Name of Elective
EXC8041	Robotics
EXC8042	Mobile Communication
EXC8043	Digital Control System
EXC8044	Biomedical Electronics

Course Code	Course Name	Te	aching Sch	Teaching Scheme			Credits Assigned				
		Theory	Practical	Tutorial	Theory	Practical	Tutorial	Total			
EXC806	Project - II		04			02		02			

Course	Course Name	Examination Scheme							
Code		Theory Marks				Term	Practical	Oral	Total
		Internal assessment			End Sem.	Work			
		Test	Test	Ave. Of	Exam				
		1	2	Test 1 and					
				Test 2					
EXC806	Project - II					50	-	50	100

The final year students have already under gone project assignment in their seventh semester and in this semester the students are expected to continue the project work of stage I.

The college should keep proper assessment record of the progress of project and at the end of the semester it should be assessed for awarding TW marks. The TW should be examined by approved internal faculty appointed by the head of the institute on the basis of following:

- Scope and objective of the project work.
- Extensive Literature survey.
- Progress of the work (Continuous assessment)
- Design, implementation, and analysis of the project work.
- Results, conclusions and future scope.
- Report in prescribed University format.

An approved external examiner and internal examiner appointed by the head of the institute together will assess during oral examination. The oral examination is a presentation by the group members on the project along with demonstration of the work done. In the examination each individual student should be assessed for his/her contribution, understanding and knowledge gained.